TOSHIBA Transistor Silicon NPN Epitaxial Planar Type

# 2SC5085

### VHF~UHF Band Low Noise Amplifier Applications

• Low noise figure, high gain.

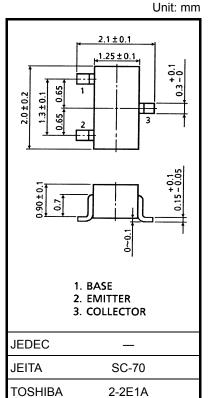
• NF = 1.1dB,  $|S_{21e}|^2 = 11dB$  (f = 1 GHz)

### Absolute Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit	
Collector-base voltage	$V_{CBO}$	20	V	
Collector-emitter voltage	$V_{CEO}$	12	V	
Emitter-base voltage	$V_{EBO}$	3	<b>V</b>	
Base current	ΙΒ	40	mA	
Collector current	IC	80	mA	
Collector power dissipation	PC	100	mW	
Junction temperature	Tj	125	°C	
Storage temperature range	T <sub>stg</sub>	-55~125	°C	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).



Weight: 0.006 g (typ.)

### Microwave Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit	
Transition frequency	f <sub>T</sub>	V <sub>CE</sub> = 10 V, I <sub>C</sub> = 20 mA	5	7	_	GHz	
Insertion gain	S <sub>21e</sub>   <sup>2</sup> (1)	1) V <sub>CE</sub> = 10 V, I <sub>C</sub> = 20 mA, f = 500 MHz —		16.5	_	dB	
	S <sub>21e</sub>   <sup>2</sup> (2)	V <sub>CE</sub> = 10 V, I <sub>C</sub> = 20 mA, f = 1 GHz	7.5	11	_	uБ	
Noise figure	NF (1)	V <sub>CE</sub> = 10 V, I <sub>C</sub> = 5 mA, f = 500 MHz	5 mA, f = 500 MHz 1		_	dB	
	NF (2)	V <sub>CE</sub> = 10 V, I <sub>C</sub> = 5 mA, f = 1 GHz	_	1.1	2	ub	

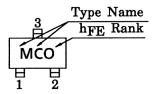
### **Electrical Characteristics (Ta = 25°C)**

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I <sub>CBO</sub>	V <sub>CB</sub> = 10 V, I <sub>E</sub> = 0	_	_	1	μА
Emitter cut-off current	I <sub>EBO</sub>	V <sub>EB</sub> = 1 V, I <sub>C</sub> = 0	_	_	1	μА
DC current gain	h <sub>FE</sub> (Note 1)	V <sub>CE</sub> = 10 V, I <sub>C</sub> = 20 mA	80	_	240	
Output capacitance	C <sub>ob</sub>	\/ 10\/  - 0 f 1 M   = (Note 2)	_	1.0	_	pF
Reverse transfer capacitance	C <sub>re</sub>	$V_{CB} = 10 \text{ V}, I_E = 0, f = 1 \text{ MHz} \text{ (Note 2)}$	_	0.65	1.15	pF

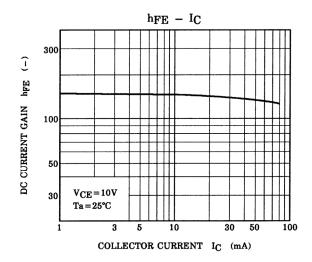
Note 1: hFE classification O: 80~160, Y: 120~240

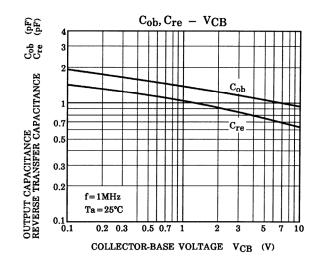
Note 2: C<sub>re</sub> is measured by 3 terminal method with capacitance bridge.

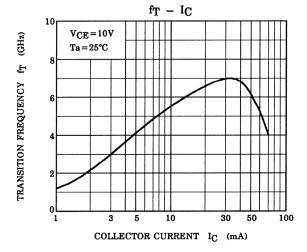
# Marking

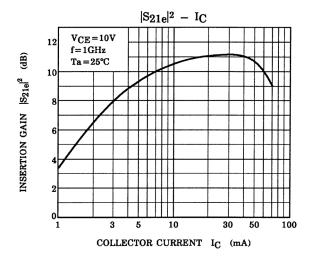


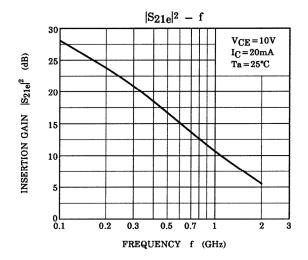
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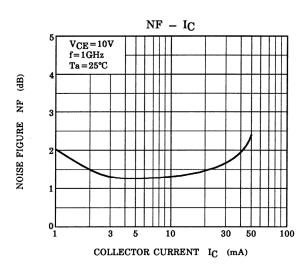




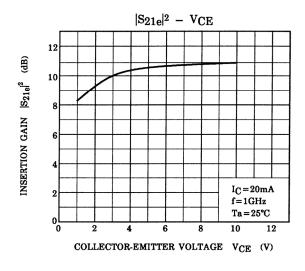


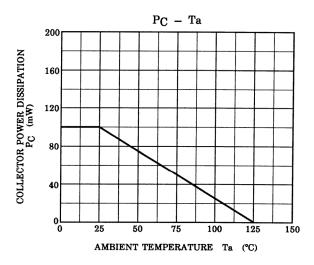






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## S-Parameter $Z_O = 50 \Omega$ , $Ta = 25^{\circ}C$

## $\mbox{V}_{\mbox{CE}} = \mbox{10 V}, \mbox{ I}_{\mbox{C}} = \mbox{5 mA}$

Frequency	S	11	S	21	S	12	S	22
(MHz)	Mag.	Ang.	Mag.	Ang.	Mag.	Ang.	Mag.	Ang.
200	0.672	-73.0	9.460	128.6	0.052	53.6	0.707	-31.3
400	0.498	-115.9	6.268	105.9	0.068	46.8	0.513	-36.2
600	0.443	-141.7	4.554	93.3	0.078	49.0	0.437	-36.6
800	0.426	-158.7	3.556	84.5	0.088	53.2	0.401	-36.8
1000	0.422	-171.9	2.948	77.5	0.099	57.9	0.383	-38.3
1200	0.428	177.5	2.526	71.1	0.113	62.7	0.373	-40.6
1400	0.437	168.3	2.240	65.5	0.133	65.8	0.367	-43.9
1600	0.449	159.9	1.997	60.1	0.152	67.6	0.362	-48.2
1800	0.464	153.1	1.821	55.0	0.171	68.7	0.358	-52.8
2000	0.485	146.7	1.686	50.9	0.195	70.6	0.350	-57.6

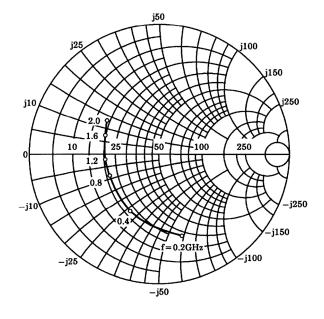
### $V_{CE} = 10 \text{ V}, I_C = 20 \text{ mA}$

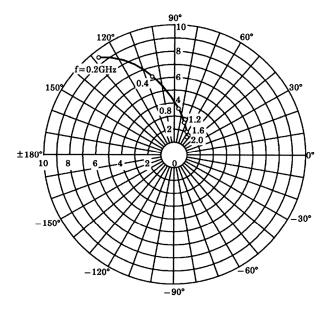
Frequency	S	11	S2	21	S1	2	S2	22
(MHz)	Mag.	Ang.	Mag.	Ang.	Mag.	Ang.	Mag.	Ang.
200	0.392	-116.4	16.247	109.3	0.034	59.7	0.420	-43.7
400	0.329	-152.1	8.775	94.5	0.054	66.0	0.280	-38.4
600	0.321	-170.6	6.018	86.3	0.075	69.5	0.244	-33.7
800	0.321	177.5	4.598	80.2	0.097	70.7	0.231	-31.7
1000	0.324	167.9	3.767	74.8	0.119	71.2	0.225	-31.3
1200	0.332	160.3	3.191	70.0	0.142	71.3	0.225	-32.7
1400	0.341	153.5	2.812	65.2	0.168	70.0	0.225	-36.2
1600	0.352	146.6	2.502	60.7	0.190	68.4	0.222	-40.3
1800	0.362	142.2	2.264	56.5	0.212	66.8	0.217	-44.9
2000	0.379	137.7	2.092	52.8	0.236	66.3	0.212	-49.4

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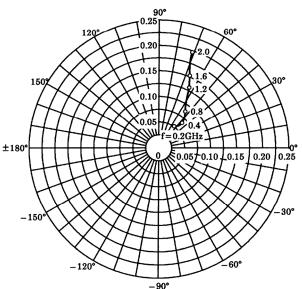
 $\begin{array}{l} S_{11e} \\ V_{CE} = 10V \\ I_{C} = 5mA \\ Ta = 25^{\circ}C \\ (UNIT:\Omega) \end{array}$ 





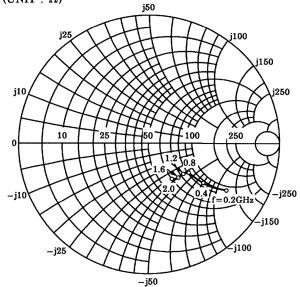


 $\begin{array}{l} \mathrm{S}_{12e} \\ \mathrm{V}_{CE} \!=\! 10\mathrm{V} \\ \mathrm{I}_{C} \!=\! 5\mathrm{mA} \\ \mathrm{Ta} \!=\! 25^{\circ}\! \mathrm{C} \end{array}$ 



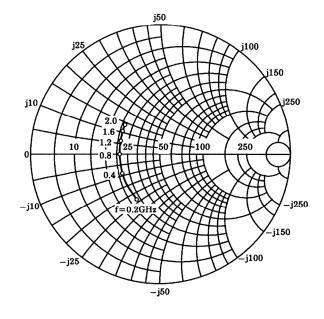
 $\begin{array}{l} S_{22e} \\ V_{CE} = 10V \\ I_{C} = 5mA \\ Ta = 25^{\circ}C \\ (UNIT: \Omega) \end{array}$ 

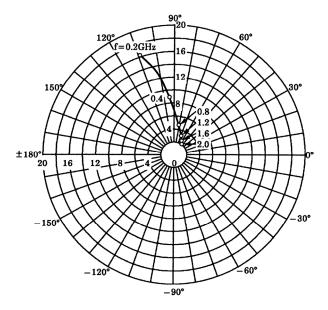
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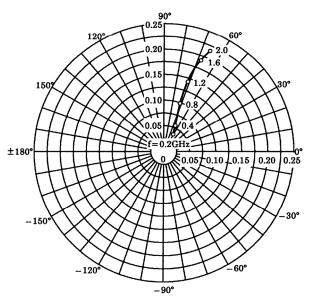
 $\begin{array}{l} S_{11e} \\ V_{CE} = 10V \\ I_{C} = 20 mA \\ Ta = 25 ^{\circ}C \\ (UNIT:\Omega) \end{array}$ 





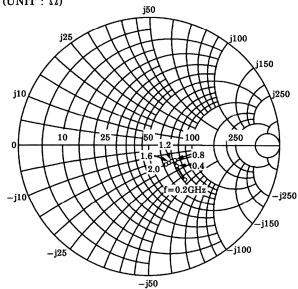


 $\begin{array}{l} S_{12e} \\ V_{CE} = 10V \\ I_{C} = 20 mA \\ Ta = 25 ^{\circ}C \end{array}$ 



 $\begin{array}{l} S_{22e} \\ V_{CE} = 10V \\ I_{C} = 20 mA \\ Ta = 25 ^{\circ}C \\ (UNIT: \Omega) \end{array}$ 

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20070701-EN GENERAL

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